eGaN® FET DATASHEET EPC2033

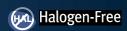
EPC2033 – Enhancement Mode Power Transistor

 V_{DS} , 150 V $R_{DS(on)}$, $7\,m\Omega$ I_D, 48 A









Gallium Nitride's exceptionally high electron mobility and low temperature coefficient allows very low R_{DS(on)}, while its lateral device structure and majority carrier diode provide exceptionally low Q_G and zero Q_{RR}. The end result is a device that can handle tasks where very high switching frequency, and low on-time are beneficial as well as those where on-state losses dominate.

	Maximum Ratings		
	PARAMETER	VALUE	UNIT
V _{DS}	Drain-to-Source Voltage (Continuous)	150	V
	Continuous ($T_A = 25$ °C, $R_{\theta JA} = 4$ °C/W)	48	Α
I _D	Pulsed (25°C, $T_{PULSE} = 300 \mu s$)	260	A
.,	Gate-to-Source Voltage	6	V
V _{GS}	Gate-to-Source Voltage	-4	V
TJ	Operating Temperature	-40 to 150	°C
T _{STG}	Storage Temperature	-40 to 150	

		**********	ATTENDED WINNESS	
(2)	9	9	9	(2)
(3)	(3)	(3)	(3)	(3)
	((2)	(3)	(2)
(2)	(3)	(2)		(2)
(2)	(2)	(2)	(2)	(2)

EPC2033 eGaN® FETs are supplied only in passivated die form with solder bumps. Die Size: 4.6 mm x 2.6 mm

- High Frequency DC-DC Conversion
- Motor Drive
- · Industrial Automation
- · Class-D Audio

	Thermal Characteristics		
	PARAMETER	ТҮР	UNIT
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	0.45	
$R_{\theta JB}$	Thermal Resistance, Junction-to-Board	3.9	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient (Note 1)	45	

Note 1: R_{BIA} is determined with the device mounted on one square inch of copper pad, single layer 2 oz copper on FR4 board. See https://epc-co.com/epc/documents/product-training/Appnote_Thermal_Performance_of_eGaN_FETs.pdf for details.

	Static Character	istics (T _J = 25°C unless otherwise stated)				
	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
BV_DSS	Drain-to-Source Voltage	$V_{GS} = 0 \text{ V, } I_D = 0.7 \text{ mA}$	150			V
I_{DSS}	Drain-Source Leakage	$V_{GS} = 0 \text{ V}, V_{DS} = 120 \text{ V}$		0.1	0.5	mA
	Gate-to-Source Forward Leakage	$V_{GS} = 5 V$		1	8	mA
I_{GSS}	Gate-to-Source Reverse Leakage	$V_{GS} = -4 V$		0.1	0.5	mA
$V_{GS(TH)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}$, $I_D = 9 \text{ mA}$	0.8	1.4	2.5	V
R _{DS(on)}	Drain-Source On Resistance	$V_{GS} = 5 \text{ V}, I_D = 25 \text{ A}$		5	7	mΩ
V_{SD}	Source-Drain Forward Voltage	$I_S = 0.5 \text{ A}, V_{GS} = 0 \text{ V}$		1.9		V

All measurements were done with substrate connected to source.

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	Dynamic Characteristics	(T _J = 25°C unless otherwise stated)				
	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
C _{ISS}	Input Capacitance			1160	1400	
C_{RSS}	Reverse Transfer Capacitance	$V_{DS} = 120 \text{ V}, V_{GS} = 0 \text{ V}$		6		
C_{OSS}	Output Capacitance			480	720	pF
C _{OSS(ER)}	Effective Output Capacitance, Energy Related (Note 2)	$V_{DS} = 0$ to 120 V, $V_{GS} = 0$ V		670		
C _{OSS(TR)}	Effective Output Capacitance, Time Related (Note 3)	$V_{DS} = 0$ to 120 V, $V_{GS} = 0$ V		900		
R_{G}	Gate Resistance			0.5		Ω
Q_{G}	Total Gate Charge	$V_{DS} = 120 \text{ V}, V_{GS} = 5 \text{ V}, I_D = 25 \text{ A}$		12	15	
Q_GS	Gate-to-Source Charge			3.8		
Q_GD	Gate-to-Drain Charge	$V_{DS} = 120 \text{ V}, I_D = 25 \text{ A}$		3.2		nC
$Q_{G(TH)}$	Gate Charge at Threshold			2.8		nc
Qoss	Output Charge	$V_{DS} = 120 \text{ V}, V_{GS} = 0 \text{ V}$		90	135	
Q_{RR}	Source-Drain Recovery Charge			0		

All measurements were done with substrate connected to source.

Note 2: $C_{OSS(ER)}$ is a fixed capacitance that gives the same stored energy as C_{OSS} while V_{DS} is rising from 0 to 50% BV_{DSS} .

Note 3: $C_{OSS(TR)}$ is a fixed capacitance that gives the same charging time as C_{OSS} while V_{DS} is rising from 0 to 50% BV_{DSS} .

Figure 1: Typical Output Characteristics at 25°C

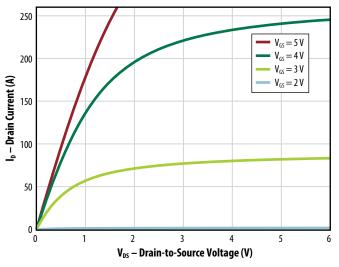


Figure 2: Transfer Characteristics

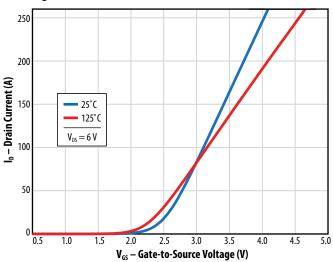


Figure 3: R_{DS(on)} vs. V_{GS} for Various Drain Currents

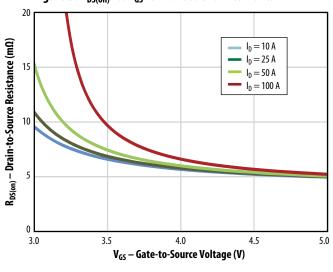
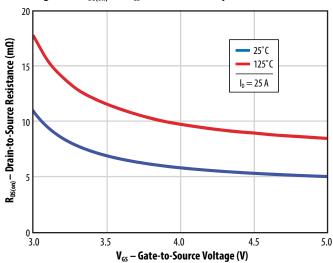


Figure 4: R_{DS(on)} vs. V_{GS} for Various Temperatures



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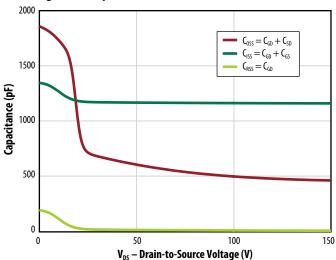


Figure 5b: Capacitance (Log Scale)

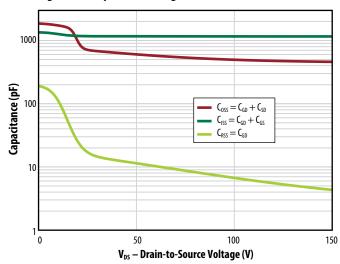


Figure 6: Gate Charge

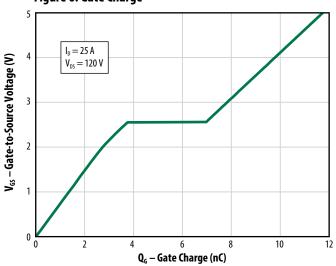


Figure 7: Reverse Drain-Source Characteristics

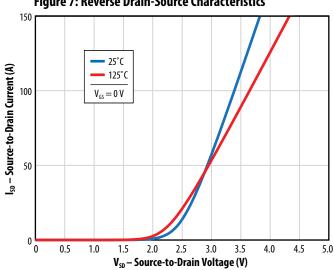


Figure 8: Normalized On-State Resistance vs. Temperature

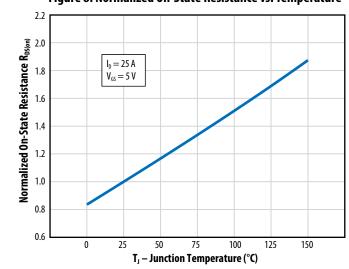
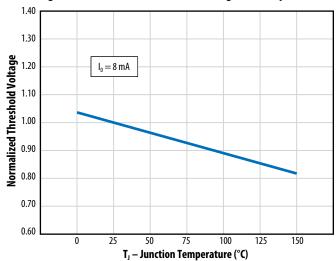


Figure 9: Normalized Threshold Voltage vs. Temperature



All measurements were done with substrate shortened to source. TJ= 25°C unless otherwise stated.

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Figure 10: Gate Leakage Current

40

25°C

125°C

125°C

10

10

10

10

V₆₅ – Gate-to-Source Voltage (V)

Figure 11: Safe Operating Area

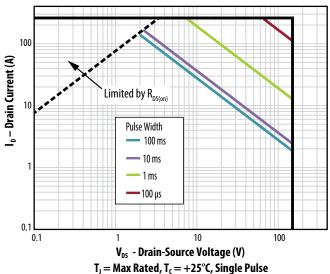
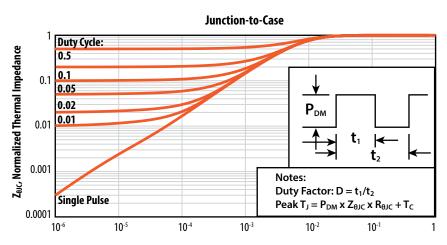
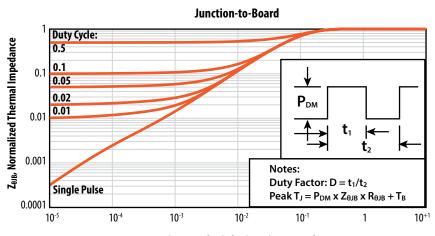


Figure 12: Transient Thermal Response Curves



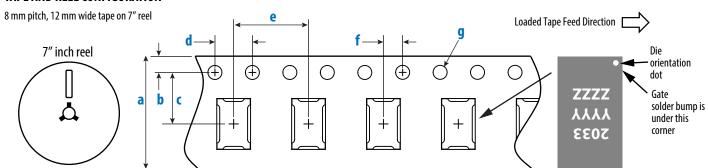
t_p, Rectangular Pulse Duration, seconds



t_p, Rectangular Pulse Duration, seconds

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TAPE AND REEL CONFIGURATION



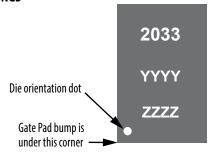
	Dime	ension (r	nm)
EPC2033 (Note 1)	Target	MIN	MAX
a	12.00	11.90	12.30
b	1.75	1.65	1.85
(Note 2)	5.50	5.45	5.55
d	4.00	3.90	4.10
e	8.00	7.90	8.10
f (Note 2)	2.00	1.95	2.05
q	1.50	1.50	1.60

Die is placed into pocket solder bump side down (face side down)

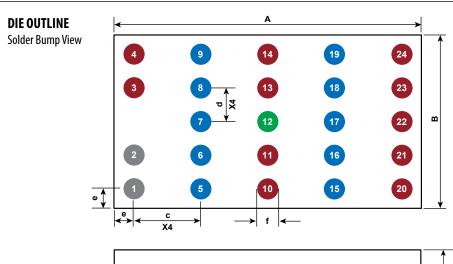
Note 1: MSL 1 (moisture sensitivity level 1) classified according to IPC/ JEDEC industry standard.

Note 2: Pocket position is relative to the sprocket hole measured as true position of the pocket, not the pocket hole.

DIE MARKINGS



D4		Laser Markings	
Part Number	Part # Marking Line 1	Lot_Date Code Marking Line 2	Lot_Date Code Marking Line 3
EPC2033	2033	YYYY	ZZZZ



DIM		Micrometers	
DIM	MIN	Nominal	MAX
A	4570	4600	4630
В	2570	2600	2630
c	1000	1000	1000
d	500	500	500
e	285	300	315
f	332	369	406

Pads 1 and 2 are Gate;

Pads 5, 6, 7, 8, 9, 15, 16, 17, 18, 19 are Drain;

Pads 3, 4, 10, 11, 13, 14, 20, 21, 22, 23, 24 are

Source;

Pad 12 is Substrate*

*Substrate pin should be connected to Source

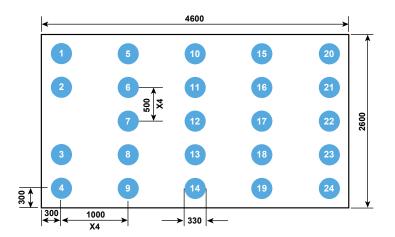
Seating plane 87 1

Side View

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RECOMMENDED LAND PATTERN

(units in µm)



Land pattern is solder mask defined Solder mask opening is 330 μm It is recommended to have on-Cu trace PCB vias

Pads 1 and 2 are Gate;

Pads 5, 6, 7, 8, 9, 15, 16, 17, 18, 19 are Drain;

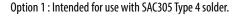
Pads 3, 4, 10, 11, 13, 14, 20, 21, 22, 23, 24 are Source;

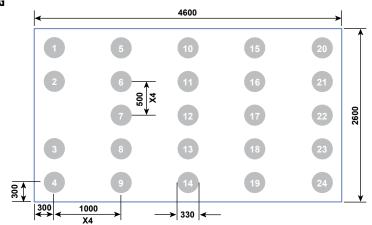
Pad 12 is Substrate*

*Substrate pin should be connected to Source

RECOMMENDED STENCIL DRAWING

(units in μ m)





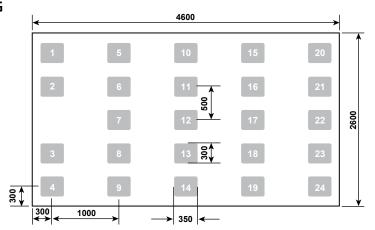
Recommended stencil should be 4 mil (100 μ m) thick, must be laser cut, openings per drawing.

Additional assembly resources available at https://epc-co.com/epc/DesignSupport/AssemblyBasics.aspx

RECOMMENDED STENCIL DRAWING

(units in µm)

Option 2: Intended for use with SAC305 Type 3 solder.



Recommended stencil should be 4 mil (100 μ m) thick, must be laser cut, openings per drawing.

Additional assembly resources available at https://epc-co.com/epc/DesignSupport/AssemblyBasics.aspx

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Information subject to change without notice.
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